

Search Notes



Application/Control No.

09/755,353

Examiner

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Applicant(s)/Patent under Reexamination

BERNING ET AL.

Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner
705	1	12/05	STN
	7		
	8		
	9		
	10		
235	383		
	385		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	12/05	STN
Patent Pg Pub		
II FOREIGN		
III NPL		
1. Fdxt 1		
2. ↓ 2		
3 Nffext		
Reviewing Parent 12/05		